

10/755,961

FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1	ATTORNEY DOCKET NO.	SERIAL NO.
	4041K-000166	<u>To be assigned</u>
	APPLICANT	
	Fumiaki Kato et al	
	FILING DATE	GROUP
	January 12, 2004	3744

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes No	
1.	<i>AVC</i>	9-20128	1/1997	Japan	—	Abstract	
2.	<i>AVC</i>	6-42015	2/1994	Japan	—	Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	

Examiner: <i>AVC</i>	Date Considered: <i>12/11/2006</i>
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Paper No. 20040112



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**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**
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Sheet 1 of 1

ATTORNEY DOCKET NO.

4041K-000166

SERIAL NO.

10/755,961

APPLICANT

Fumiaki Kato, et al.

FILING DATE

01/12/2004

GROUP

~~3753~~ 3744**U.S. PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	AKC	6,170,522	01/2001	Tanida		

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	AKC	49-77564	06/1974	Japan			X
2.		60-87812	06/1985	Japan			X
3.		62-98095	05/1987	Japan			X
4.		01-126489	05/1989	Japan		Abstract	
5.		4-64689	06/1992	Japan			X
6.		B-2515328	08/1996	Japan			X
7.		08-338585	12/1996	Japan		Abstract	
8.		11-132573	05/1999	Japan		Abstract	
9.		11-236990	08/1999	Japan		US	
10.		2001-349486	12/2001	Japan		Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	AKC	Office Action for corresponding Japanese Patent Application No. 2003-005611 mailed August 21, 2006.

Examiner:

AKC

Date Considered:

12/11/2006

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